

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250849US2S		SERIAL NO. <u>10/805460</u> New Application <u>1</u>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Koji SAKUI			
				FILING DATE Filed with <u>3/22/2004</u>		GROUP <u>2827</u>	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
<u>HK</u>	AA	5,777,925	07/07/98	Kaoru TOKUSHIGE	<u>1</u>	<u>1</u>	
<u>I</u>	AB	4,636,984	01/13/87	Hans R. NEUKOMM	<u>I</u>	<u>I</u>	
	AC	6,307,807	10/23/01	Koji SAKUI, et al.	<u>I</u>	<u>I</u>	
	AD	6,370,081	04/09/02	Koji SAKUI, et al.	<u>I</u>	<u>I</u>	
<u>HK</u>	AE	6,512,703	01/28/03	Koji SAKUI, et al.	<u>I</u>	<u>I</u>	
	AF						
	AG						
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	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION			
				YES	NO		
<u>HK</u>	AO	11-195718	07/21/99	Japan		X	
<u>I</u>	AP	11-297081	10/29/99	Japan		X	
	AQ	2000-149581	05/30/00	Japan		X	
<u>HK</u>	AR	2002-43444	02/08/02	Japan		X	
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
<u>HK</u>	AW	Art LANCASTER, et al. "A 5V-Only EEPROM with Internal Program/Erase Control", ISSCC DIGEST OF TECHNICAL PAPERS, 1983 IEEE International Solid-State Circuits Conference, Session XIII: NONVOLATILE MEMORY, February 24, 1983, Page 164-165 and Page 302					
<u>I</u>	AX	Fujio MASUOKA, et al., "New Ultra High Density EPROM and Flash EEPROM with NAND Structure Cell", IEDM 87, Pages 552-555					
<u>I</u>	AY	Fujio MASUOKA, et al., "A New Flash E ² PROM Cell Using Triple Polysilicon Technology", IEDM 84, Pages 464-467					
<u>HK</u>	AZ	William S. JOHNSON, et al. "A 16Kb Electrically Erasable Nonvolatile Memory" DIGEST OF TECHNICAL PAPERS, 1980 IEEE International Solid-State Circuits Conference, Session XII: ROMs, PROMs and EROMs, February 14, 1980, Page 152-153 and Page 271				<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <u>Huan Hoang</u>				Date Considered <u>11/17/05</u>			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



Serial No. 10/805,460

Group 2827

LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Patent Appl. Publication No.</u>	<u>Inventor/ Applicant</u>
250849US2S*	10/805,460	03/22/04	US 2004/0240273 A1	SAKUI
checked 268304US2S	11/083,156	03/18/05		HASEGAWA et al.

HB

11/17/05

*Present Application; listed for information

EHK/abd/akh

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